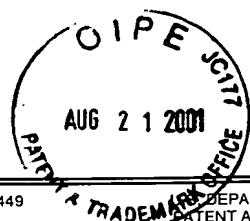


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210131US0PCT		SERIAL NO. 09/857,214	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hayao TANAKA			
		FILING DATE		GROUP			
		June 22, 2001		1772			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
WBA	AA	4 472 357	09/18/84	Didya D. LEVY et al.	422	102	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	0 137 292	04/17/85	EP	YES	NO	No
	AP	08-033472	02/06/96	JP	YES	NO	No
WBA	AQ	1 401 233	07/16/75	GB	YES	NO	No
	AR				YES	NO	
	AS				YES	NO	
	AT				YES	NO	
	AU				YES	NO	
	AV				YES	NO	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW					RECEIVED MAR 9 2002 1000 1700	
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner	<i>Hayao TANAKA</i>				Date Considered 08/07/02		

\*Examiner: Initial if reference is considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449 (Modified)		DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210131US0PCT	SERIAL NO. 09/857,214	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hayao TANAKA		
		FILING DATE		GROUP		
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					
	AM					
	AN					
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
WPA	AO	60-91983	05/23/85	JAPAN (with English Abstract)		X
	AP	4-19561	01/23/92	JAPAN		X
	AQ	10-114800	05/06/98	JAPAN		X
	AR	6-174726	06/24/94	JAPAN (with English Abstract)		X
↓	AS	7-128336	05/19/95	JAPAN (with English Abstract)		X
	AT					
	AU					
	AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
	AW					
	AX					
	AY					
	AZ					
Examiner <i>Mark Blayden</i>		Date Considered 08/07/02				

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

RECEIVED  
AUG 23 2001  
TC 1700